



30V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)}	I _D T _A = +25°C
30V	460m $Ω$ @ V _{GS} = 4.5 V	1.2A
	560m $Ω$ @ V _{GS} = 2.5 V	1.0A

Description

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Load Switch
- Portable Applications
- Power Management Functions





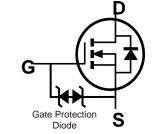
Bottom View

Features and Benefits

- 0.4mm Ultra Low Profile Package for Thin Application
- 0.6mm² Package Footprint, 10 times Smaller than SOT23
- Low V_{GS(TH)}. Can Be Driven Directly From A Battery
- Low R_{DS(ON)}
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

- Case: X2-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound;
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe; Solderable per MIL-STD-202, Method 208 64
- Weight: 0.001 grams (Approximate)



Equivalent Circuit

Ordering Information (Note 4)

Part Number	Marking	Reel Size (inches)	Tape Width (mm)	Tape Pitch (mm)	Quantity Per Reel
DMN3731UFB4-7B	BR	7	8	2	10,000

Notes:

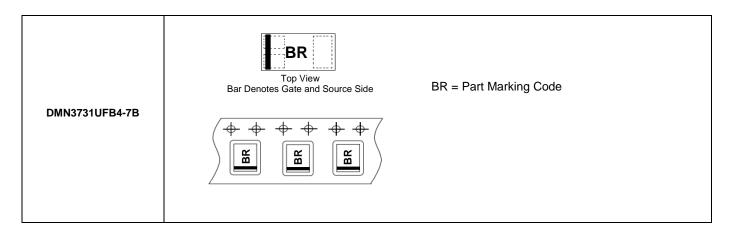
- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

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Top View

- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information





Characteristic			Symbol	Value	Unit	
Drain-Source Voltage			V _{DSS}	30	\/	
Gate-Source Voltage			V _{GSS}	±8	V	
Continuous Drain Current (Note 6) $V_{GS} = 4.5V$ Steady $T_A = +25^{\circ}C$ State $T_A = +70^{\circ}C$		I _D	1.2 0.9	А		
Maximum Continuous Body Diode Forward Current (Note 6)			Is	1.2	А	
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)			I _{DM}	3	Α	

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)		P_{D}	0.52	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{ heta JA}$	240	°C/W
Total Power Dissipation (Note 6)		PD	0.97	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	129	°C/W
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

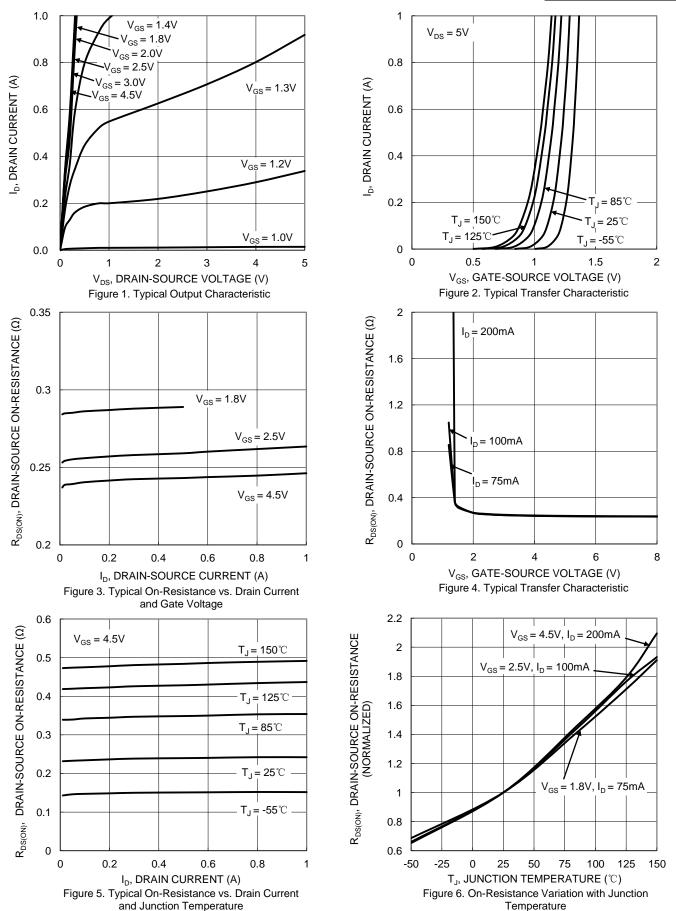
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 10\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μΑ	$V_{DS} = 30V$, $V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	3	μA	$V_{GS} = \pm 8V$, $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(TH)}	0.45	_	0.95	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
		_	297	460		$V_{GS} = 4.5V, I_D = 200mA$	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	311	560	mΩ	$V_{GS} = 2.5V, I_D = 100mA$	
		_	335	730		$V_{GS} = 1.8V, I_D = 75mA$	
Diode Forward Voltage	V _{SD}	_	1.0	1.2	V	$V_{GS} = 0V, I_S = 300 \text{mA}$	
DYNAMIC CHARACTERISTICS (Note 8)		·					
Input Capacitance	C _{iss}	_	73	_	pF	271111	
Output Capacitance	Coss	_	7.2		pF	$V_{DS} = 25V, V_{GS} = 0V,$ - f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	5	_	pF	T = 1.0(VII) 12	
Gate Resistance	Rg	_	902	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge	Qg	_	5.5	_	nC		
Gate-Source Charge	Qgs	_	0.8	_	nC	$V_{GS} = 4.5V, V_{DS} = 15V,$	
Gate-Drain Charge	Q _{gd}	_	1.4	_	nC	$I_D = 1A$	
Turn-On Delay Time	t _{D(ON)}	_	2.5	_	ns		
Turn-On Rise Time	t _R	_	3.1	_	ns	$V_{DS} = 10V, I_{D} = 1A$	
Turn-Off Delay Time	t _{D(OFF)}	_	477	_	ns	$V_{GS} = 10V, R_G = 6\Omega$	
Turn-Off Fall Time	t _F	_	123	_	ns		
Reverse Recovery Time	t _{RR}		59		ns	$I_F = 1A$, $di/dt = 100A/\mu s$	
Reverse Recovery Charge	Q_{RR}		25	_	nC	I _F = 1A, di/dt = 100A/μs	

Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to production testing.











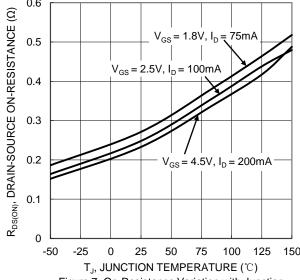


Figure 7. On-Resistance Variation with Junction Temperature

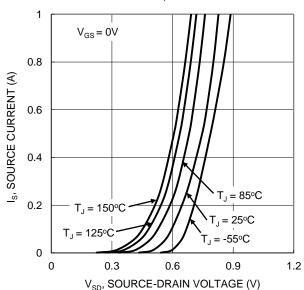
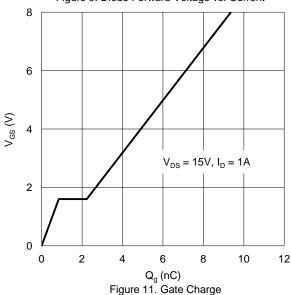


Figure 9. Diode Forward Voltage vs. Current



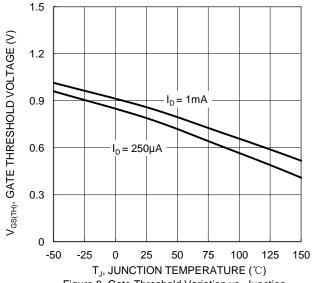


Figure 8. Gate Threshold Variation vs. Junction Temperature

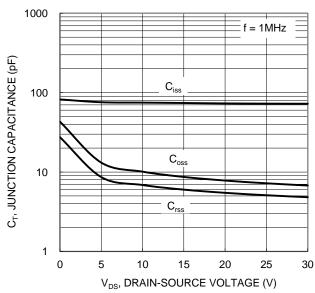


Figure 10. Typical Junction Capacitance

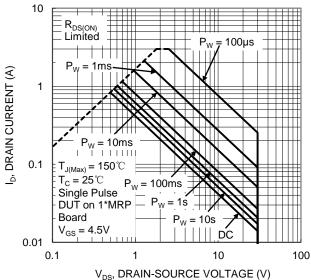


Figure 12. SOA, Safe Operation Area



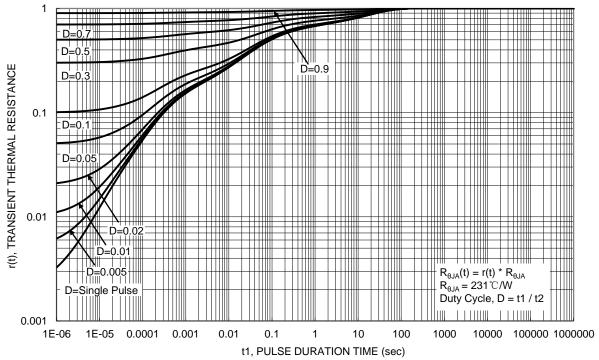


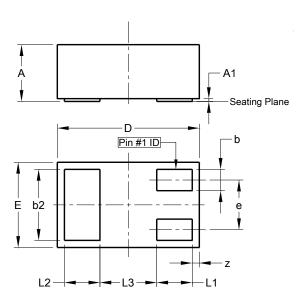
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X2-DFN1006-3

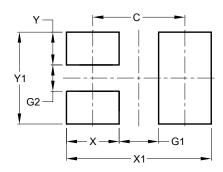


X2-DFN1006-3					
Dim	Min	Max	Тур		
Α		0.40	_		
A1	0.00	0.05	0.03		
b	0.10	0.20	0.15		
b2	0.45	0.55	0.50		
D	0.95	1.05	1.00		
Е	0.55	0.65	0.60		
е	-	-	0.35		
L1	0.20	0.30	0.25		
L2	0.20	0.30	0.25		
L3	1	1	0.40		
Z	0.02	0.08	0.05		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

X2-DFN1006-3



Dimensions	Value (in mm)
С	0.70
G1	0.30
G2	0.20
Х	0.40
X1	1.10
Y	0.25
Y1	0.70



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